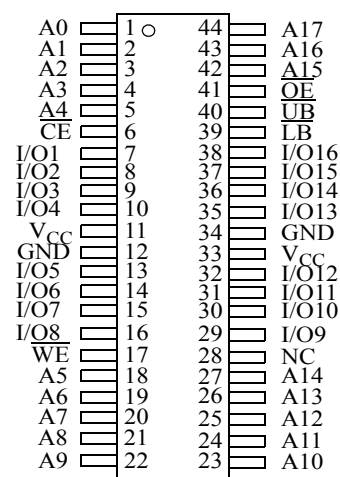


- AS7C4098 (5V version)
- AS7C34098 (3.3V version)
- Industrial and commercial temperature
- Organization: 262,144 words $\times$ 16 bits
- Center power and ground pins
- High speed
 - 10/12/15/20 ns address access time
 - 5/6/7/8 ns output enable access time
- Low power consumption: ACTIVE
 - 1375 mW (AS7C4098)/max @ 12 ns
 - 576 mW (AS7C34098)/max @ 10 ns

- Low power consumption: STANDBY
 - 110 mW (AS7C4098)/max CMOS
 - 72 mW (AS7C34098)/max CMOS
- Individual byte read/write controls
- Easy memory expansion with $\overline{\text{CE}}$, $\overline{\text{OE}}$ inputs
- TTL- and CMOS-compatible, three-state I/O
- 44-pin JEDEC standard packages
 - 400-mil SOJ
 - TSOP 2
- ESD protection ≥ 2000 volts
- Latch-up current ≥ 100 mA

The block diagram illustrates the proposed 1024 × 256 × 16 3D array architecture. It features a central **1024 × 256 × 16 Array (4,194,304)** connected to a **Row Decoder** and a **Column decoder**. The **Row Decoder** takes address inputs **A0** through **A13** and provides row selection to the array. The **Column decoder** takes address inputs **A5** through **A17** and provides column selection to the array. A **Control circuit** is connected to the array and the column decoder, receiving **I/O1-I/O8** and **I/O9-I/O16** as data inputs. The control circuit also manages the array's operation, receiving **VCC** and **GND** for power. The array's output is connected to the column decoder, which then outputs the data. The control circuit is also connected to **WE** (Write Enable), **UB** (Upper Bank Enable), **OE** (Output Enable), **LB** (Lower Bank Enable), and **CE** (Chip Enable) inputs through AND gates.

44-pin (400 mil) SOJ
TSOP2



		−10	−12	−15	−20	Unit
Maximum address access time		10	12	15	20	ns
Maximum output enable access time		5	6	7	8	ns
Maximum operating current	AS7C4098	—	250	220	180	mA
	AS7C34098	160	130	110	100	mA
Maximum CMOS standby current	AS7C4098	—	20	20	20	mA
	AS7C34098	20	20	20	20	mA



Functional description

The AS7C4098 and AS7C34098 are high-performance CMOS 4,194,304-bit Static Random Access Memory (SRAM) devices organized as 262,144 words $\times$ 16 bits. They are designed for memory applications where fast data access, low power, and simple interfacing are desired.

Equal address access and cycle times (t_{AA} , t_{RC} , t_{WC}) of 10/12/15/20 ns with output enable access times (t_{OE}) of 5/6/7/8 ns are ideal for high-performance applications. The chip enable input $\overline{CE}$ permits easy memory expansion with multiple-bank memory systems.

When $\overline{CE}$ is High the device enters standby mode. The standard AS7C4098/AS7C34098 is guaranteed not to exceed 110/72mW power consumption in CMOS standby mode. A write cycle is accomplished by asserting write enable ($\overline{WE}$) and chip enable ($\overline{CE}$). Data on the input pins I/O1–I/O16 is written on the rising edge of $\overline{WE}$ (write cycle 1) or $\overline{CE}$ (write cycle 2). To avoid bus contention, external devices should drive I/O pins only after outputs have been disabled with output enable ($\overline{OE}$) or write enable ($\overline{WE}$).

A read cycle is accomplished by asserting output enable ($\overline{OE}$) and chip enable ($\overline{CE}$), with write enable ($\overline{WE}$) High. The chip drives I/O pins with the data word referenced by the input address. When either chip enable or output enable is inactive, or write enable is active, output drivers stay in high-impedance mode.

These devices provide multiple center power and ground pins, and separate byte enable controls, allowing individual bytes to be written and read. $\overline{LB}$ controls the lower bits, I/O1–I/O8, and $\overline{UB}$ controls the higher bits, I/O9–I/O16.

All chip inputs and outputs are TTL- and CMOS-compatible, and operation is from either a single 5V (AS7C4098) or 3.3V (AS7C34098) supply. Both devices are available in the JEDEC standard 400-mL, 44-pin SOJ and TSOP 2 packages.

Absolute maximum ratings

Parameter	Device	Symbol	Min	Max	Unit
Voltage on V_{CC} relative to GND	AS7C4098	V_{t1}	–0.50	+7.0	V
	AS7C34098	V_{t1}	–0.50	+5.0	V
Voltage on any pin relative to GND		V_{t2}	–0.50	$V_{CC} + 0.50$	V
Power dissipation		P_D	–	1.5	W
Storage temperature		T_{stg}	–65	+150	°C
Ambient temperature with V_{CC} applied		T_{bias}	–55	+125	°C
DC current into outputs (low)		I_{OUT}	–	± 20	mA

Note: Stresses greater than those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Truth table

$\overline{CE}$	$\overline{WE}$	$\overline{OE}$	$\overline{LB}$	$\overline{UB}$	I/O1–I/O8	I/O9–I/O16	Mode
H	X	X	X	X	High Z	High Z	Standby (I_{SB} , I_{SB1})
L	H	H	X	X	High Z	High Z	Output disable (I_{CC})
L	X	X	H	H			
L	H	L	L	H	D_{OUT}	High Z	Read (I_{CC})
			H	L	High Z	D_{OUT}	
			L	L	D_{OUT}	D_{OUT}	
L	L	X	L	H	D_{IN}	High Z	Write (I_{CC})
			H	L	High Z	D_{IN}	
			L	L	D_{IN}	D_{IN}	

Key: X = Don't care, L = Low, H = High.



Recommended operating conditions

Parameter		Symbol	Min	Typical	Max	Unit
Supply voltage	AS7C4098	V_{CC} (12/15/20)	4.5	5.0	5.5	V
	AS7C34098	V_{CC} (10)	3.15	3.3	3.6	V
	AS7C34098	V_{CC} (12/15/20)	3.0	3.3	3.6	V
Input voltage	AS7C4098	V_{IH}	2.2	–	$V_{CC} + 0.5$	V
	AS7C34098	V_{IH}	2.0	–	$V_{CC} + 0.5$	V
		V_{IL}^1	–0.5	–	0.8	V
Ambient operating temperature	commercial	T_A	0	–	70	°C
	industrial	T_A	–40	–	85	°C

¹ V_{IL} min = –1.0V for pulse width less than 5ns.

DC operating characteristics (over the operating range)¹

Parameter	Symbol	Test conditions		-10		-12		-15		-20		Unit
				Min	Max	Min	Max	Min	Max	Min	Max	
Input leakage current	I _{LI}	V _{CC} = Max V _{IN} = GND to V _{CC}	AS7C4098/ AS7C34098	–	1	–	1	–	1	–	1	μA
Output leakage current	I _{LO}	V _{CC} = Max CE = V _{IH} or OE = V _{IH} or WE = V _{IL} V _{I/O} = GND to V _{CC}	AS7C4098/ AS7C34098	–	1	–	1	–	1	–	1	μA
Operating power supply current	I _{CC}	V _{CC} = Max	AS7C4098	–	–	–	250	–	220	–	180	mA
		Min cycle, 100% duty CE = V _{IL} , I _{OUT} = 0mA	AS7C34098	–	160	–	130	–	110	–	100	mA
Standby power supply current	I _{SB}	V _{CC} = Max CE = V _{IH} , f = Max	AS7C4098	–	–	–	60	–	60	–	60	mA
			AS7C34098	–	60	–	60	–	60	–	60	mA
	I _{SB1}	V _{CC} = Max CE ≥ V _{CC} – 0.2V, V _{IN} ≥ V _{CC} – 0.2V or V _{IN} ≤ 0.2V, f = 0	AS7C4098	–	–	–	20	–	20	–	20	mA
			AS7C34098	–	20	–	20	–	20	–	20	mA
Output voltage	V _{OL}	I _{OL} = 8 mA, V _{CC} = Min	AS7C4098/ AS7C34098	–	0.4	–	0.4	–	0.4	–	0.4	V
	V _{OH}	I _{OH} = –4 mA, V _{CC} = Min	AS7C34098	2.4	–	2.4	–	2.4	–	2.4	–	V

Capacitance ($f = 1\text{MHz}$, $T_a = 25^\circ\text{C}$, $V_{CC} = \text{NOMINAL}$)²

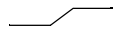
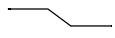
Parameter	Symbol	Signals	Test conditions	Max	Unit
Input capacitance	C_{IN}	A, $\overline{CE}$, $\overline{WE}$, $\overline{OE}$, $\overline{UB}$, $\overline{LB}$	$V_{IN} = 0\text{V}$	6	pF
I/O capacitance	$C_{I/O}$	I/O	$V_{IN} = V_{OUT} = 0\text{V}$	8	pF



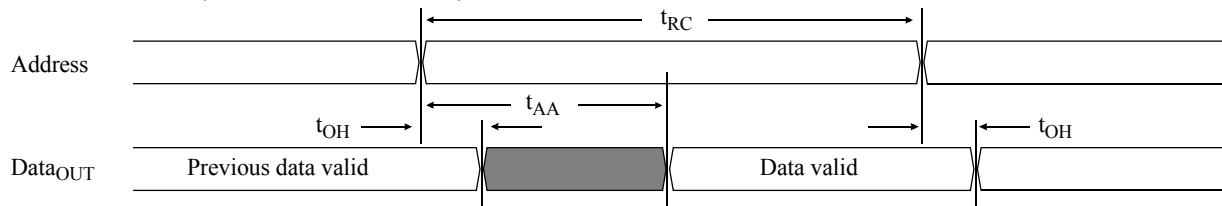
Read cycle (over the operating range)^{3,9}

Parameter	Symbol	-10		-12		-15		-20		Unit	Notes
		Min	Max	Min	Max	Min	Max	Min	Max		
Read cycle time	t_{RC}	10	–	12	–	15	–	20	–	ns	
Address access time	t_{AA}	–	10	–	12	–	15	–	20	ns	
Chip enable ($\overline{CE}$) access time	t_{ACE}	–	10	–	12	–	15	–	20	ns	
Output enable ($\overline{OE}$) access time	t_{OE}	–	5	–	6	–	7	–	8	ns	
Output hold from address change	t_{OH}	3	–	3	–	3	–	3	–	ns	5
$\overline{CE}$ Low to output in low Z	t_{CLZ}	0	–	3	–	0	–	0	–	ns	4, 5
$\overline{CE}$ High to output in high Z	t_{CHZ}	–	5	–	6	–	7	–	9	ns	4, 5
$\overline{OE}$ Low to output in low Z	t_{OLZ}	0	–	0	–	0	–	0	–	ns	4, 5
$\overline{OE}$ High to output in high Z	t_{OHZ}	–	5	–	6	–	7	–	9	ns	4, 5
$\overline{LB}$, $\overline{UB}$ access time	t_{BA}	–	5	–	6	–	7	–	8	ns	
$\overline{LB}$, $\overline{UB}$ Low to output in low Z	t_{BLZ}	0	–	0	–	0	–	0	–	ns	
$\overline{LB}$, $\overline{UB}$ High to output in high Z	t_{BHZ}	–	5	–	6	–	7	–	9	ns	
Power up time	t_{PU}	0	–	0	–	0	–	0	–	ns	5
Power down time	t_{PD}	–	10	–	12	–	15	–	20	ns	5

Key to switching waveforms

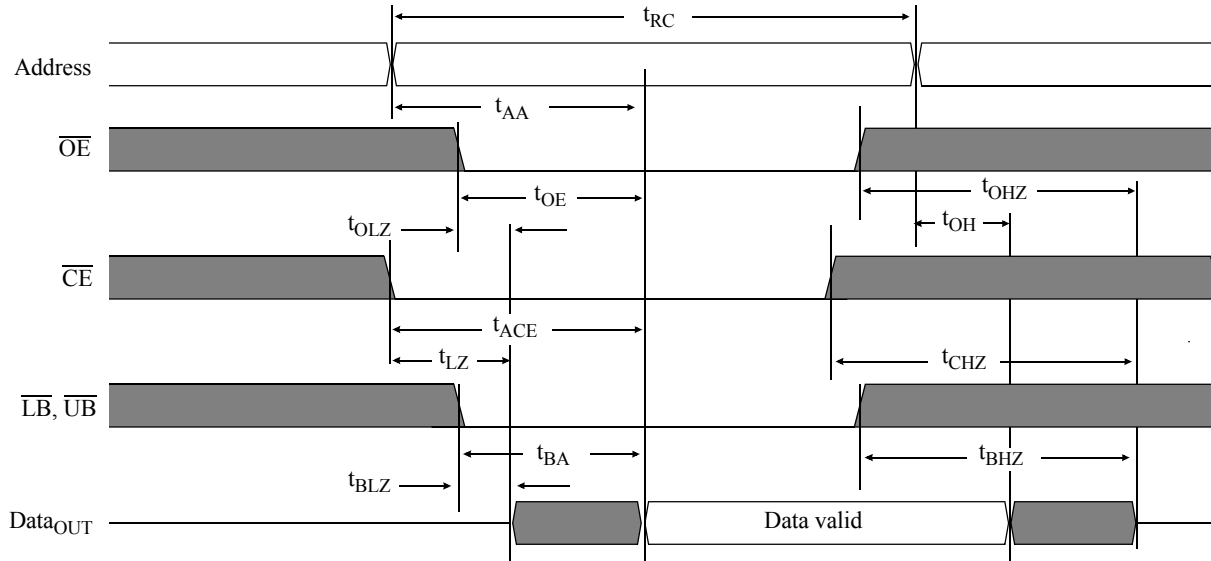
 Rising input
  Falling input
  Undefined/don't care

Read waveform 1 (address controlled)^{6,7,9}





Read waveform 2 ($\overline{\text{CE}}$, $\overline{\text{OE}}$, $\overline{\text{UB}}$, $\overline{\text{LB}}$ controlled)^{6,8,9}

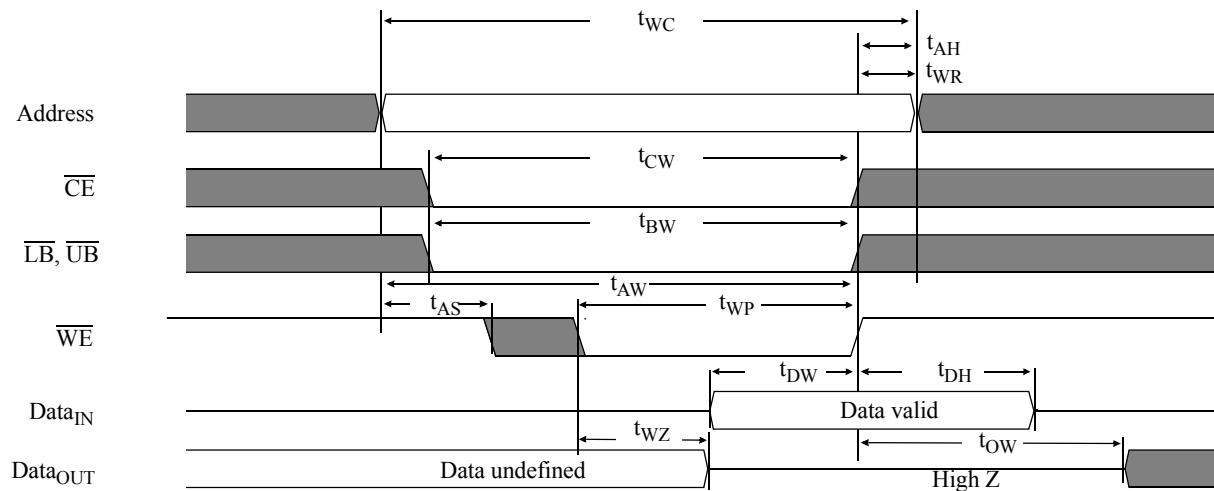


Write cycle (over the operating range)¹¹

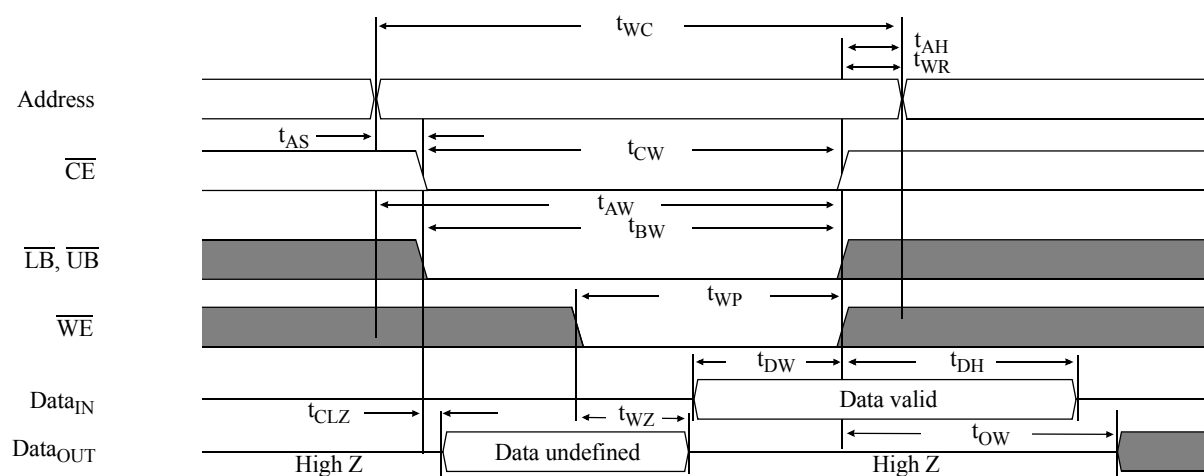
Parameter	Symbol	-10		-12		-15		-20		Unit	Note
		Min	Max	Min	Max	Min	Max	Min	Max		
Write cycle time	t_{WC}	10	—	12	—	15	—	20	—	ns	
Chip enable ($\overline{\text{CE}}$) to write end	t_{CW}	7	—	8	—	10	—	12	—	ns	
Address setup to write end	t_{AW}	7	—	8	—	10	—	12	—	ns	
Address setup time	t_{AS}	0	—	0	—	0	—	0	—	ns	
Write pulse width ($\overline{\text{OE}} = \text{High}$)	t_{WP1}	7	—	8	—	10	—	12	—	ns	
Write pulse width ($\overline{\text{OE}} = \text{Low}$)	t_{WP2}	10	—	12	—	15	—	20	—	ns	
Write recovery time	t_{WR}	0	—	0	—	0	—	0	—	ns	
Address hold from end of write	t_{AH}	0	—	0	—	0	—	0	—	ns	
Data valid to write end	t_{DW}	5	—	6	—	7	—	9	—	ns	
Data hold time	t_{DH}	0	—	0	—	0	—	0	—	ns	4, 5
Write enable to output in High-Z	t_{WZ}	0	5	0	6	0	7	0	9	ns	4, 5
Output active from write end	t_{OW}	3	—	3	—	3	—	3	—	ns	4, 5
Byte enable Low to write end	t_{BW}	7	—	8	—	10	—	12	—	ns	4, 5



Write waveform 1 ($\overline{\text{WE}}$ controlled)^{10,11}

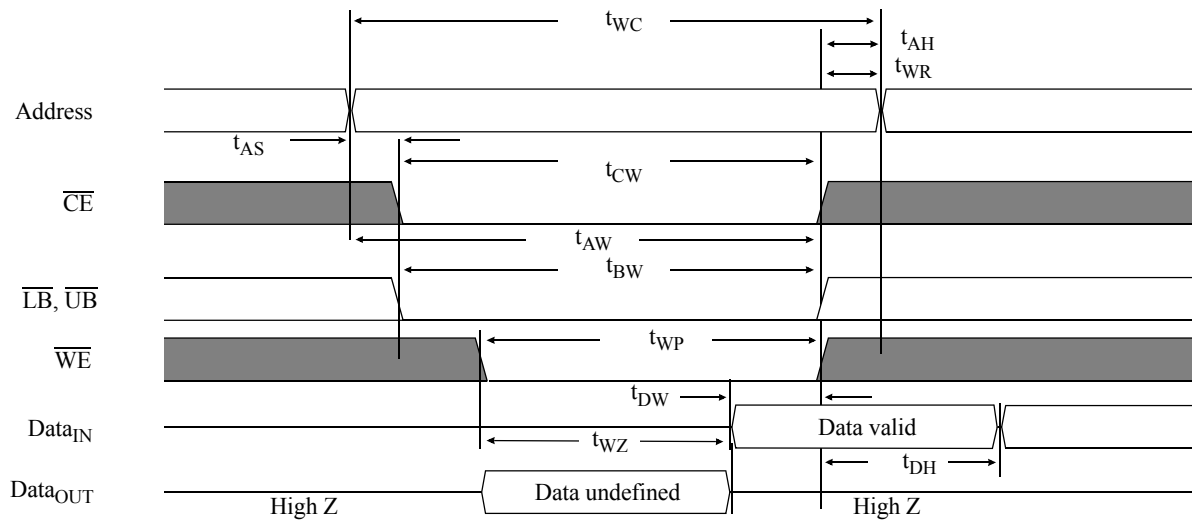


Write waveform 2 ($\overline{\text{CE}}$ controlled)^{10,11}





Write waveform 3^{10,11}



AC test conditions

- Output load: see Figure B or Figure C.
- Input pulse level: GND to 3.0V. See Figure A.
- Input rise and fall times: 2 ns. See Figure A.
- Input and output timing reference levels: 1.5V.

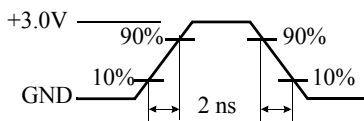


Figure A: Input pulse

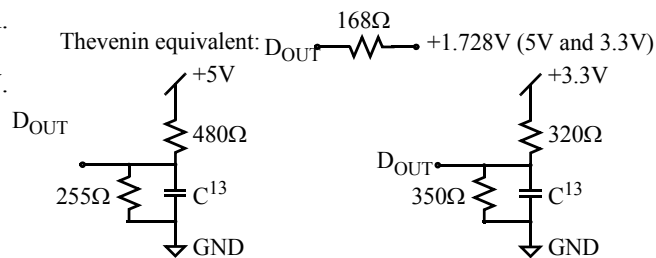


Figure B: 5V Output load

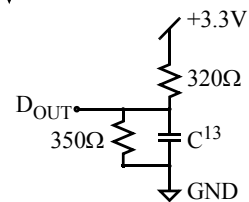


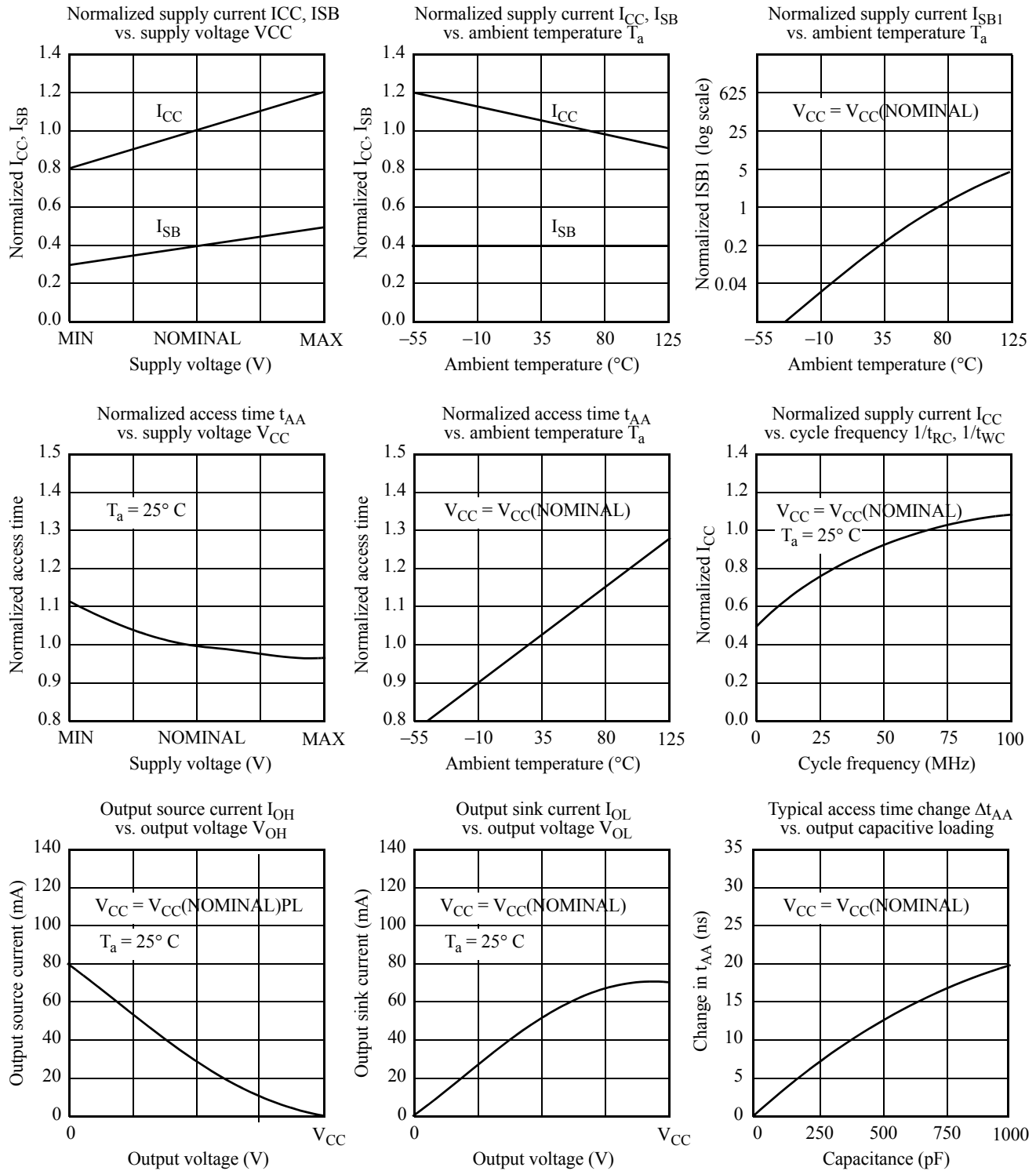
Figure C: 3.3V Output load

Notes

- 1 During V_{CC} power-up, a pull-up resistor to V_{CC} on $\overline{CE}$ is required to meet I_{SB} specification.
- 2 This parameter is sampled, but not 100% tested.
- 3 For test conditions, see *AC Test Conditions*, Figures A, B, C.
- 4 t_{CLZ} and t_{CHZ} are specified with $C_L = 5\text{pF}$ as in Figure C. Transition is measured $\pm 500\text{mV}$ from steady-state voltage.
- 5 This parameter is guaranteed, but not tested.
- 6 $\overline{WE}$ is High for read cycle.
- 7 $\overline{CE}$ and $\overline{OE}$ are Low for read cycle.
- 8 Address valid prior to or coincident with $\overline{CE}$ transition Low.
- 9 All read cycle timings are referenced from the last valid address to the first transitioning address.
- 10 $\overline{CE}$ or $\overline{WE}$ must be High during address transitions. Either $\overline{CE}$ or $\overline{WE}$ asserting high terminates a write cycle.
- 11 All write cycle timings are referenced from the last valid address to the first transitioning address.
- 12 Not applicable.
- 13 $C = 30\text{pF}$, except on High Z and Low Z parameters, where $C = 5\text{pF}$.

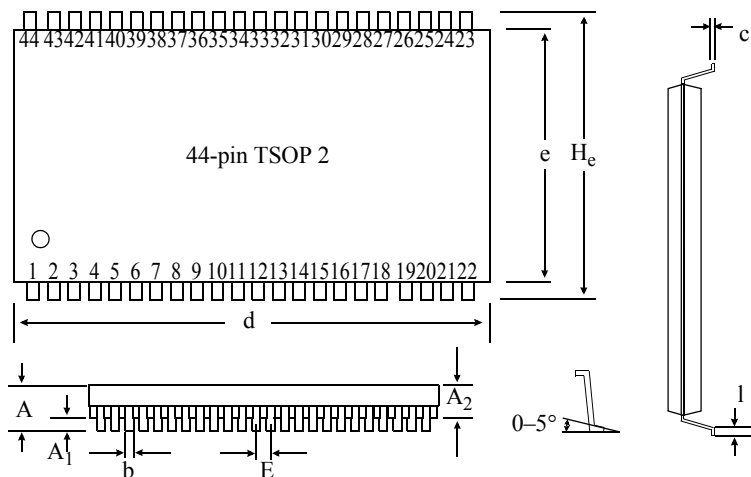


Typical DC and AC characteristics¹²

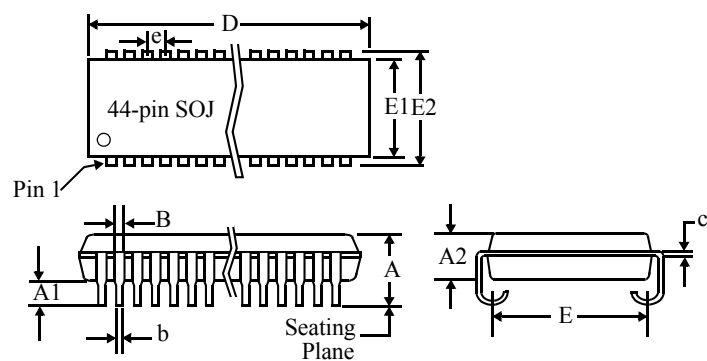




Package dimensions



	44-pin TSOP 2	
	Min (mm)	Max (mm)
A		1.2
A₁	0.05	0.15
A₂	0.95	1.05
b	0.30	0.45
c	0.12	0.21
d	18.31	18.52
e	10.06	10.26
H_e	11.68	11.94
E	0.80 (typical)	
l	0.40	0.60



	44-pin SOJ 400 mils	
	Min(mils)	Max(mils)
A	0.128	0.148
A₁	0.025	-
A₂	0.105	0.115
B	0.026	0.032
b	0.015	0.020
c	0.007	0.013
D	1.120	1.130
E	0.370 NOM	
E₁	0.395	0.405
E₂	0.435	0.445
e	0.050 NOM	



Ordering Codes

Package	Version	10 ns	12 ns	15 ns	20 ns
SOJ	5V commercial	NA	AS7C4098-12JC	AS7C4098-15JC	AS7C4098-20JC
	5V industrial	NA	AS7C4098-12JI	AS7C4098-15JI	AS7C4098-20JI
	3.3V commercial	AS7C34098-10JC	AS7C34098-12JC	AS7C34098-15JC	AS7C34098-20JC
	3.3V industrial	NA	AS7C34098-12JI	AS7C34098-15JI	AS7C34098-20JI
TSOP 2	5V commercial	NA	AS7C4098-12TC	AS7C4098-15TC	AS7C4098-20TC
	5V industrial	NA	AS7C4098-12TI	AS7C4098-15TI	AS7C4098-20TI
	3.3V commercial	AS7C34098-10TC	AS7C34098-12TC	AS7C34098-15TC	AS7C34098-20TC
	3.3V industrial	NA	AS7C34098-12TI	AS7C34098-15TI	AS7C34098-20TI

Note:

Add suffix "N" to the above part number for lead free devices, Ex. AS7C4098-12JCN

Part numbering system

AS7C	X	4098	-XX	J or T	X	N
SRAM prefix	Voltage: Blank: 5V CMOS 3: 3.3V CMOS	Device number	Access time	Packages: J: SOJ 400 mil T: TSOP 2	Temperature ranges: C: Commercial, 0°C to 70°C I: Industrial, -40°C to 85°C	Lead free device



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.